

WITHDRAWAL OF ADOPTION NOTICE

The document ASTM-F1192M, "MEASUREMENT OF SINGLE EVENT PHENOMENA (SEP) INDUCED BY HEAVY ION IRRADIATION OF SEMICONDUCTOR DEVICES (METRIC)" has been withdrawn by ASTM and replaced by ASTM-F1192. Therefore, the Department of Defense has determined that it no longer has an interest in ASTM-F1192M, and is hereby withdrawing its adoption of this document as of May 1, 2012.

Adopting Activity:

DLA-CC

(Project 5962-2012-005)

Custodians:

Army - CR
Navy - EC
Air Force - 85
DLA - CC
Others-NA

Reviewer Activities:

Army - AR, MI, SM
Navy - AS, CG, MC, OS, SH
Air Force-19, 99